International **IOR** Rectifier

POWER MOSFET SURFACE MOUNT(SMD-1)

Product Summary

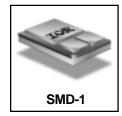
Part Number	RDS(on)	ID	
IRFN9140	0.20Ω	-18A	

HEXFET® MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

Absolute Maximum Ratings

PD - 91553D

IRFN9140 JANTX2N7236U JANTXV2N7236U REF:MIL-PRF-19500/595 100V, P-CHANNEL HEXFET[®] MOSFETTECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Surface Mount
- Dynamic dv/dt Rating
- Light-weight

	Parameter		Units
ID @ VGS = -10V, TC = 25°C	Continuous Drain Current	-18	
ID @ VGS = -10V, TC = 100°C	Continuous Drain Current	-11	A
IDM	Pulsed Drain Current ①	-72	
P _D @ T _C = 25°C	Max. Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	EAS Single Pulse Avalanche Energy 2		mJ
IAR	Avalanche Current ①	-18	A
EAR	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt Peak Diode Recovery dv/dt 3		-5.0	V/ns
Тј	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Package Mounting Surface Temperature	300 (for 5 S)	
	Weight	2.6(typical)	g

For footnotes refer to the last page

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Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	-100	-	—	V	$V_{GS} = 0V, I_{D} = -1.0mA$
ΔBV _{DSS} /ΔTJ	Temperature Coefficient of Breakdown Voltage	_	-0.087	—	V/°C	Reference to 25°C, $I_D = -1.0$ mA
RDS(on)	Static Drain-to-Source On-State		—	0.20	0	VGS = -10V, ID = -11A@
	Resistance		—	0.22	Ω	$V_{GS} = -10V, I_{D} = -18A @$
VGS(th)	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$
9fs	Forward Transconductance	6.2	—	—	S (ឋ)	V _{DS} > -15V, I _{DS} = -11A@
IDSS	Zero Gate Voltage Drain Current	_	—	-25		V _{DS} = -80V, V _{GS} = 0V
			—	-250	μA	V _{DS} = -80V
						$V_{GS} = 0V, T_{J} = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	—	-100	nA	V _{GS} = -20V
IGSS	Gate-to-Source Leakage Reverse		—	100		$V_{GS} = 20V$
Qg	Total Gate Charge	_	—	60		$V_{GS} = -10V, ID_{=} -18A$
Qgs	Gate-to-Source Charge	_	—	13	nC	V _{DS} = -50V
Q _{gd}	Gate-to-Drain ('Miller') Charge	_	—	35.2		
^t d(on)	Turn-On Delay Time	_	—	35		V _{DD} = -50V, I _D = -18A
tr	Rise Time	_	—	85	ns	RG =9.1Ω, VGS = -10V
^t d(off)	Turn-Off Delay Time		—	85	115	
tf	Fall Time	_	—	65		
L _{S +} L _D	Total Inductance		4.0	_	nH	Measured from the center of drain pad to center of source pad
Ciss	Input Capacitance	_	1400			VGS = 0V, VDS = -25V
C _{oss}	Output Capacitance		600	—	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	200	—		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
IS	Continuous Source Current (Body	/ Diode)	_		-18	Α	
ISM	Pulse Source Current (Body Diod	e) ①	—	_	-72		
VSD	Diode Forward Voltage		_	_	-4.2	V	$T_j = 25^{\circ}C, I_S = -18A, V_{GS} = 0V ④$
t _{rr}	Reverse Recovery Time		—		280	nS	Tj = 25°C, IF = -18A, di/dt ≤-100A/μs
QRR	Reverse Recovery Charge		_	_	3.6	μc	$V_{DD} \leq -30V $
ton	Forward Turn-On Time Intrin	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by LS + LD.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
R _{th} JC	Junction to Case	—	_	1.0	°C/W	
R _{th} J-PCB	Junction to PC Board	—	4.0	—		Soldered to a copper-clad PC board

For footnotes refer to the last page

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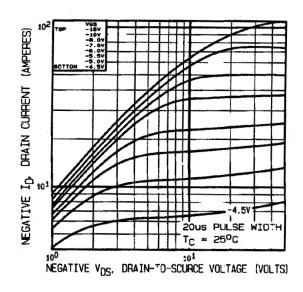


Fig 1. Typical Output Characteristics

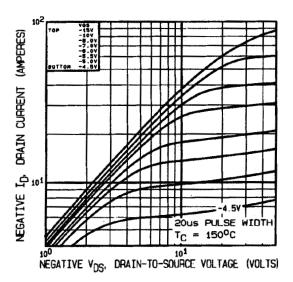


Fig 2. Typical Output Characteristics

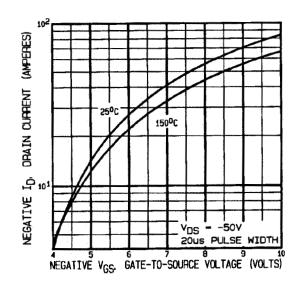


Fig 3. Typical Transfer Characteristics

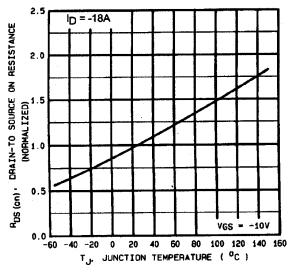


Fig 4. Normalized On-Resistance Vs. Temperature

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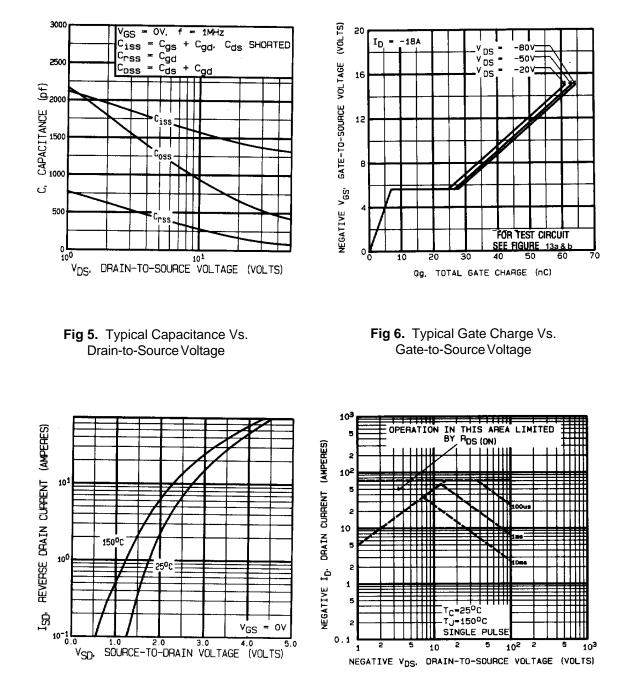
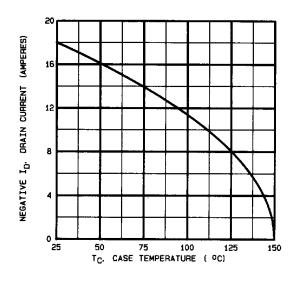
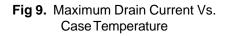


Fig 7. Typical Source-Drain Diode Forward Voltage

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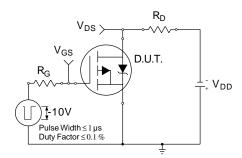


Fig 10a. Switching Time Test Circuit

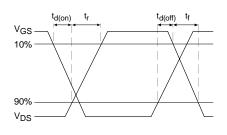


Fig 10b. Switching Time Waveforms

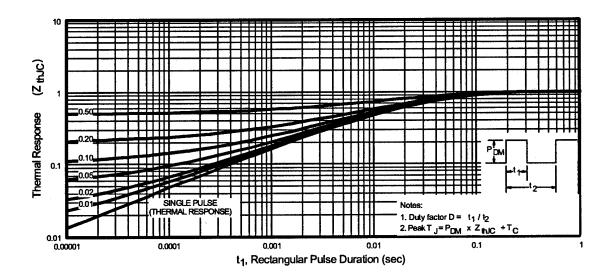


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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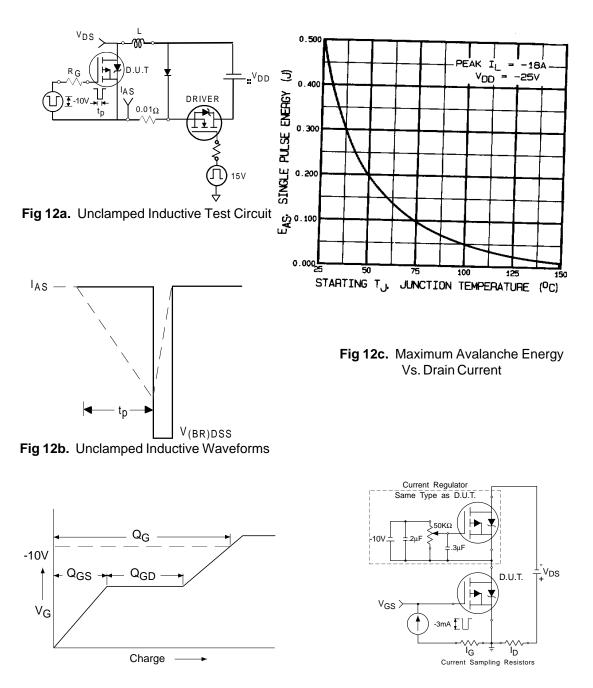


Fig 13a. Basic Gate Charge Waveform

Fig 13b. Gate Charge Test Circuit

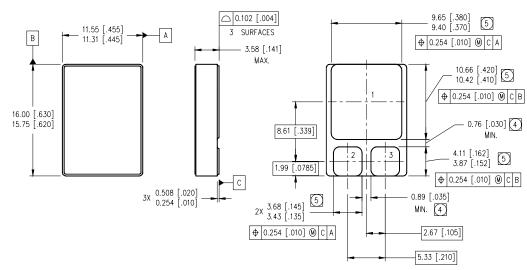
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Foot Notes:

1 Repetitive Rating; Pulse width limited by maximum junction temperature.

② V_{DD} =-25V, starting T_J = 25°C, L = 3.1mH Peak II = -18A, VGS = -10V

- $(3) I_{SD} \leq -18A, di/dt \leq -100A/\mu s,$ $V_{DD} \le -100V$, $T_J \le 150^{\circ}C$
- ④ Pulse width \leq 300 µs; Duty Cycle \leq 2%



Case Outline and Dimensions — SMD-1

NOTES:

- 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
- CONTROLLING DIMENSION: INCH. 2.
- 3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 4 DIMENSION INCLUDES METALLIZATION FLASH.
- DIMENSION DOES NOT INCLUDE METALLIZATION FLASH.



PAD ASSIGNMENTS

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